Small Signal MOSFET

-8.0 V, -3.7 A, Single P-Channel, SOT-23

Features

- Leading Trench Technology for Low R_{DS(on)}
- -1.8 V Rated for Low Voltage Gate Drive
- SOT-23 Surface Mount for Small Footprint (3 x 3 mm)
- This is a Pb-Free Device

Applications

- High Side Load Switch
- DC-DC Conversion
- Cell Phone, Notebook, PDAs, etc.

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

| Parameter | | | Symbol | Value | Unit |
|---|-------------------------------|-----------------------|--------------------------------------|---------------|------|
| Drain-to-Source Voltage | | | V_{DSS} | -8.0 | V |
| Gate-to-Source Voltage | | | V _{GS} | ±8.0 | V |
| Continuous Drain | t ≤ 5 s T _A = 25°C | | I _D | -3.7 | Α |
| Current (Note 1) | | T _A = 70°C | | -3.0 | |
| Power Dissipation (Note 1) | t: | ≤ 5 s | P _D | 0.96 | W |
| Pulsed Drain Current | t _p = | 10 μs | I _{DM} | -11 | Α |
| Operating Junction and Storage Temperature | | | T _J , T _{STG} | –55 to 150 | °C |
| Source Current (Body Diode) | | | I _S | -1.2 | Α |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s) | | | T_L | 260 | °C |

THERMAL RESISTANCE RATINGS

| Parameter | Symbol | Max | Unit |
|------------------------------------|-----------------|-----|------|
| Junction-to-Ambient - Steady State | $R_{\theta JA}$ | 160 | °C/W |
| Junction-to-Ambient - t ≤ 5 s | $R_{\theta JA}$ | 130 | |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

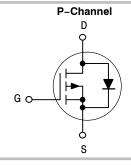
1. Surface mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).



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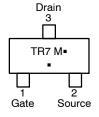
| V _{(BR)DSS} | R _{DS(on)} Typ | I _D Max |
|----------------------|-------------------------|--------------------|
| | 39 mΩ @ -4.5 V | |
| -8.0 V | 52 mΩ @ -2.5 V | –3.7 A |
| | 79 mΩ @ –1.8 V | |



MARKING DIAGRAM & PIN ASSIGNMENT



SOT-23 CASE 318 STYLE 21



TR7 = Specific Device Code
M = Date Code*
= Pb-Free Package

(Note: Microdot may be in either location)

*Date Code orientation may vary depending upon manufacturing location.

ORDERING INFORMATION

| Device | Package | Shipping [†] | | |
|-------------|---------------------|-----------------------|--|--|
| NTR2101PT1G | SOT-23 (Pb-Free) | 3000/Tape & Reel | | |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise stated)

| Parameter | Symbol | Test Condition | | Min | Тур | Max | Unit |
|--|--------------------------------------|--|------------------------|-------|--------|------|-------|
| OFF CHARACTERISTICS | | | | | | • | |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | $V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$ | | -8.0 | | | V |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | V _{(BR)DSS} /T _J | | | | 10 | | mV/°C |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{GS} = 0 V, | T _J = 25°C | | | -1.0 | μΑ |
| | | $V_{DS} = -6.4 \text{ V}$ | T _J = 125°C | | | -100 | |
| Gate-to-Source Leakage Current | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 8.0 \text{ V}$ | | | | ±100 | nA |
| ON CHARACTERISTICS (Note 2) | | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | $V_{GS} = V_{DS}, I_D =$ | = -250 μA | -0.40 | | -1.0 | V |
| Negative Threshold Temperature Coefficient | V _{GS(TH)} /T _J | | | | 0.0027 | | mV/°C |
| Drain-to-Source On Resistance | R _{DS(on)} | $R_{DS(on)}$ $V_{GS} = -4.5 \text{ V}, I_D = -3.5 \text{ A}$ | | | 39 | 52 | mΩ |
| | | $V_{GS} = -2.5 \text{ V}, I_D = -3.0 \text{ A}$ | | | 52 | 72 | |
| | | $V_{GS} = -1.8 \text{ V}, I_D = -2.0 \text{ A}$ | | | 79 | 120 | |
| Forward Transconductance | 9FS | $V_{GS} = -5.0 \text{ V}, I_D = -3.5 \text{ A}$ | | | 9.0 | | S |
| CHARGES AND CAPACITANCES | | | | | | • | |
| Input Capacitance | C _{ISS} | $V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = -4.0 \text{ V}$ | | | 1173 | | pF |
| Output Capacitance | C _{OSS} | | | | 289 | | |
| Reverse Transfer Capacitance | C _{RSS} | | | | 218 | | |
| Total Gate Charge | Q _{G(TOT)} | $V_{GS} = -4.5 \text{ V}, V_{DS} = -4.0 \text{ V},$ $I_{D} = -3.5 \text{ A}$ | | | 12 | 15 | nC |
| Gate-to-Source Charge | Q _{GS} | | | | 3.8 | | 7 |
| Gate-to-Drain Charge | Q _{GD} | | | | 2.5 | | 1 |
| SWITCHING CHARACTERISTICS (Note 3) | 1 | | | | | | |
| Turn-On Delay Time | t _{d(on)} | | | | 7.4 | 15 | ns |
| Rise Time | t _r | $V_{GS} = -4.5 \text{ V}, V_{DD} = -4.0 \text{ V},$ $I_{D} = -1.2 \text{ A}, R_{G} = 6.0 \Omega$ | | | 15.75 | 25 | |
| Turn-Off Delay Time | t _{d(off)} | | | | 38 | 58 | |
| Fall Time | t _f | | | | 31 | 51 | 1 |
| DRAIN-SOURCE DIODE CHARACTERIST | rics | | | | • | | |
| Forward Diode Voltage | V _{SD} | V _{GS} = 0 V, I _S = -1.2 A | T _J = 25°C | | -0.73 | -1.2 | V |
| | | | - | | | | |

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

-I_D, DRAIN CURRENT (A)

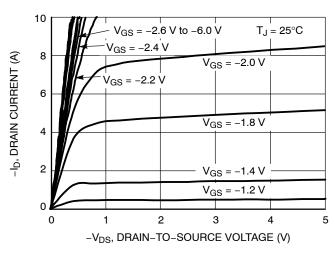


Figure 1. On-Region Characteristics

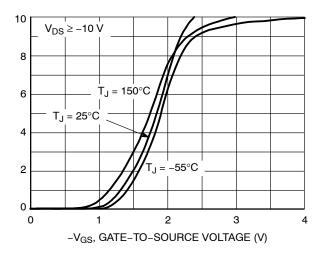


Figure 2. Transfer Characteristics

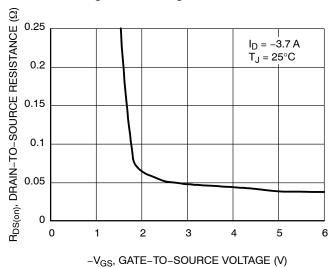


Figure 3. On-Resistance versus Gate-to-Source Voltage

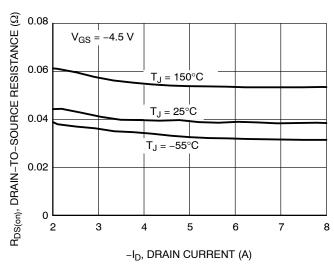


Figure 4. On-Resistance versus Drain Current and Gate Voltage

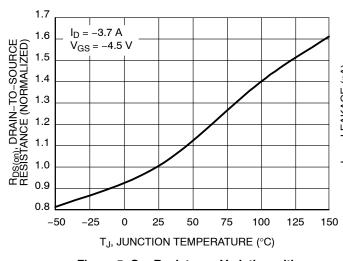


Figure 5. On–Resistance Variation with Temperature

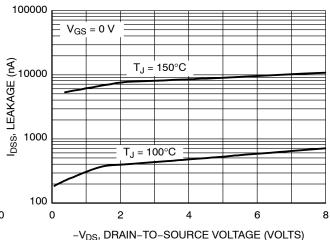
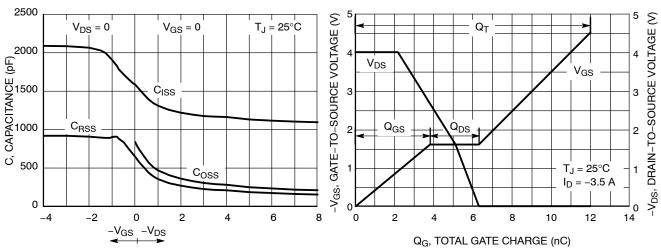


Figure 6. Drain-to-Source Leakage Current versus Voltage

TYPICAL CHARACTERISTICS



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (V)

Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

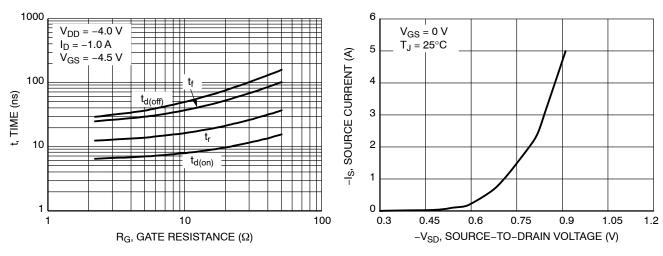


Figure 9. Resistive Switching Time Variation versus Gate Resistance

Figure 10. Diode Forward Voltage versus Current

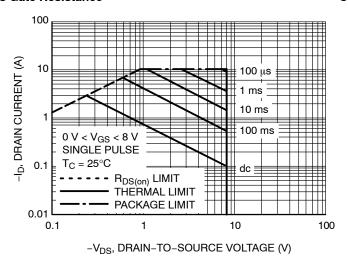


Figure 11. Maximum Rated Forward Biased Safe Operating Area

TYPICAL CHARACTERISTICS

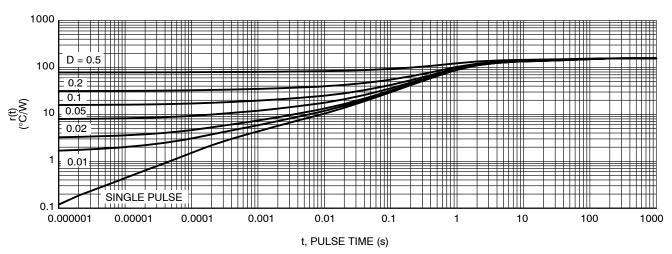
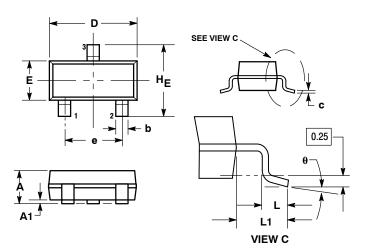


Figure 12. Thermal Response

PACKAGE DIMENSIONS

SOT-23 (TO-236) CASE 318-08 **ISSUE AP**



NOTES:

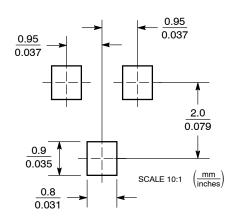
- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: INCH.
- MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH,
- PROTRUSIONS, OR GATE BURRS

| | MILLIMETERS | | | INCHES | | |
|-----|-------------|------|------|--------|-------|-------|
| DIM | MIN | NOM | MAX | MIN | NOM | MAX |
| Α | 0.89 | 1.00 | 1.11 | 0.035 | 0.040 | 0.044 |
| A1 | 0.01 | 0.06 | 0.10 | 0.001 | 0.002 | 0.004 |
| b | 0.37 | 0.44 | 0.50 | 0.015 | 0.018 | 0.020 |
| С | 0.09 | 0.13 | 0.18 | 0.003 | 0.005 | 0.007 |
| D | 2.80 | 2.90 | 3.04 | 0.110 | 0.114 | 0.120 |
| E | 1.20 | 1.30 | 1.40 | 0.047 | 0.051 | 0.055 |
| е | 1.78 | 1.90 | 2.04 | 0.070 | 0.075 | 0.081 |
| L | 0.10 | 0.20 | 0.30 | 0.004 | 0.008 | 0.012 |
| L1 | 0.35 | 0.54 | 0.69 | 0.014 | 0.021 | 0.029 |
| HE | 2.10 | 2.40 | 2.64 | 0.083 | 0.094 | 0.104 |
| θ | 0° | | 10° | 0° | | 10° |

STYLE 21:

- PIN 1. GATE
 - SOURCE
 - DRAIN 3.

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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